

<b>Notice of References Cited</b>	Application/Control No. 10/033,732	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,368,184-B1	04-2002	Beckage, Peter J.	451/9
	B	US-6,319,420-B1	11-2001	Dow, Daniel B.	216/86
	C	US-6,297,159-B1	10-2001	Paton, Eric N.	438/693
	D	US-6,190,494-B1	02-2001	Dow, Daniel B.	156/345.13
	E	US-5,985,093-A	11-1999	Chen, Lai-Juh	156/345.13
	F	US-5,823,854-A	10-1998	Chen, Lai-Juh	451/9
	G	US-5,562,529-A	10-1996	Kishii et al.	451/36
	H	US-4,793,895-A	12-1988	Kaanta et al.	438/17
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 325753 A2	08-1989	European Patent	KAANTA et al.	H01L 21/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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